


<b>Search Notes</b>  	<b>Application/Control No.</b>  10710279	<b>Applicant(s)/Patent Under Reexamination</b>  GUENOUN ET AL.
	<b>Examiner</b>  Singh, Hirdepal	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	215	6/28/07	HS
375	226	6/28/07	HS
375	243	6/28/07	HS
375	326-327	6/28/07	HS
375	355-357	6/28/07	HS
375	371-376	6/28/07	HS
327	146-150	6/28/07	HS
327	156	6/28/07	HS
375	215	8/29/07	HS
375	226	8/29/07	HS
375	243	8/29/07	HS
375	326-327	8/29/07	HS
375	355-357	8/29/07	HS
375	371-376	8/29/07	HS
327	146-150	8/29/07	HS
327	156	8/29/07	HS

SEARCH NOTES		
Search Notes	Date	Examiner
US-PG PUB; USPAT; USOCR; FPRS; EPO; JPO; IBM_TDB; DERWENT	6/28/2007	HS
US-PG PUB; USPAT; USOCR; FPRS; EPO; JPO; IBM_TDB; DERWENT	8/29/07	HS
PLUS SEARCH	8/29/07	HS
GOOGLE SEARCH	8/29/07	HS
IEEE EXPLORE	8/29/07	HS
Shuwang Liu (SPE-2611)	8/29/07	HS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	327	8/29/07	HS
375	354	8/29/07	HS
375	371	8/29/07	HS
375	376	8/29/07	HS